

## PATENT APPLICATION

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Atty. Dkt. No.: 60011US

Elwin M. BEATY et al.

Appln. No.: 09/844,232

Filed: April 27, 2001 Group Art Unit: 2625

Conf. No.: 1440 Examiner: S. Chawan

Title: METHOD AND APPARATUS FOR THREE DIMENSIONAL INSPECTION OF

ELECTRONIC COMPONENTS

## INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97

M/S Amendment Commissioner for Patents P.O. Box, 1450 Alexandria, VA 22313-1450 RECEIVED

AUG 0 6 2004

Technology Center 2600

Dear Sir:

In accordance with 37 C.F.R. § 1.56, Applicant hereby submits the following Information Disclosure Statement. The form PTO-1449 submitted, lists references that the Examiner may consider to be relevant. These documents are not necessarily analogous art. Applicant respectfully requests that these documents be considered by the Examiner, and that the Examiner indicate consideration of the cited references by returning a signed copy of the attached form PTO-1449. Copies of all the cited references are enclosed.

Respectfully submitted,

ROBERTS ABOKHAIR & MARDULA, LLC

Jon L. ROBERTS Reg. No. 31293 (703) 391-2900



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Form PTO-1449 US Dept. of Commerce (REV. 8-83) PATENT & TRADEMARK OFFICE			ATTY DOCKET NO.		APPLICATION NO.					
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			Elwin M. BEATY et al.							
				April 27, 2001	GROUP 2625					
U.S. PATENT DOCUMENTS										
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS		DATE OPRIATE		
	A	US 5245671	Sept. 1993	Kobayashi et al.	382	150				
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FOREIGN PATENT DOCUMENTS										
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)  B John Lau, BALL GRID ARRAY TECHNOLOGY, pp. 558, 561, 565, 591 (1995 McGraw-Hill)										
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EXAMINER					DATE CONSIDERED					
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; Draw line through citation if not										
in conformance and not considered. Include copy of this form with next communication to applicant.										
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